



Power Field Effect Transistor

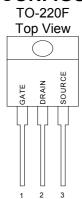
GENERAL DESCRIPTION

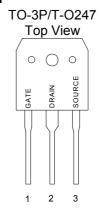
This high voltage MOSFET uses an advanced termination scheme to provide enhanced voltage-blocking capability without degrading performance over time. In addition, this advanced MOSFET is designed to withstand high energy in avalanche and commutation modes. The new energy efficient design also offers a drain-to-source diode with a fast recovery time. Designed for high voltage, high speed switching applications in power supplies, converters and PWM motor controls, these devices are particularly well suited for bridge circuits where diode speed and commutating safe operating areas are critical and offer additional and safety margin against unexpected voltage transients.

FEATURES

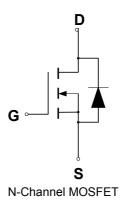
- ◆ Robust High Voltage Termination
- Avalanche Energy Specified
- Source-to-Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- ◆ Diode is Characterized for Use in Bridge Circuits
- ◆ I_{DSS} and V_{DS}(on) Specified at Elevated Temperature
- ◆ Isolated Mounting Hole Reduces Mounting Hardware

PIN CONFIGURATION





SYMBOL



ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain to Current — Continuous		20.6	Α
- Pulsed	I _{DM}	61.8	
Gate-to-Source Voltage — Continue	V_{GS}	±30	V
Total Power Dissipation – TO220FP		53	W
– TO3P		235	W/°C
– TO247		203	
Derate above 25℃ – TO220FP		0.43	
– TO3P		1.9	
– TO247		1.6	
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to 150	$^{\circ}\!\mathbb{C}$
Single Pulse Drain-to-Source Avalanche Energy $-T_J = 25^{\circ}$		1805	
$(V_{DD} = 100V, V_{GS} = 10V, I_{L} = 19A, L = 10mH, R_{G} = 25\Omega)$			mJ
Thermal Resistance — Junction to Case -TO220FP		3.5	°C/W
Junction to Case -TO3P		0.56	
 Junction to Case -TO247 		0.7	
 Junction to Ambient -TO220FP 	θ_{JA}	62.5	
 Junction to Ambient -TO3P, TO247 		40	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL	260	$^{\circ}\!\mathbb{C}$
ESD SENSITIVITY — HBM, C=100pF, R=1.5kΩ		2000	V





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ORDERING INFORMATION

Part Number	Package
GPT21N45GN3P*	TO-3P
GPT21N45GN247*	TO-247
GPT21N45DGN220FP*	TO-220F

^{*}Note: G: Suffix for PB Free Product

ELECTRICAL CHARACTERISTICS

Unless otherwise specified, $T_J = 25^{\circ}C$.

			GPT21N45			
Char	Symbol	Min	Тур	Max	Units	
Drain-Source Breakdown Voltage	V	500			V	
$(V_{GS} = 0 \text{ V}, I_D = 250 \ \mu \text{ A})$	$V_{(BR)DSS}$	500			V	
Drain-Source Leakage Current					1	uA
$(V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V})$	I _{DSS}			ı	uA	
Gate-Source Leakage Current-Forward	d				100	nA
$(V_{gsf} = 30 \text{ V}, V_{DS} = 0 \text{ V})$	I _{GSSF}			100	IIA	
Gate-Source Leakage Current-Reverse		lara-			100	nA
$(V_{gsr} = 30 \text{ V}, V_{DS} = 0 \text{ V})$		I _{GSSR}			100	nA
Gate Threshold Voltage		\ \ <u>\</u>	3		5	V
$(V_{DS} = V_{GS}, I_{D} = 250 \ \mu A)$		$V_{GS(th)}$	3		5	v
Static Drain-Source On-Resistance (V	_{GS} = 10 V, I _D = 10.5A) *	R _{DS(on)}		0.175	0.21	Ω
Forward Transconductance (V _{DS} = 50	g _{FS}		19		S	
Input Capacitance	// - 25 // // - 0 //	C _{iss}		3513		pF
Output Capacitance	$(V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$	Coss		387		pF
Reverse Transfer Capacitance	f = 1.0 MHz)	C _{rss}		12.6		pF
Turn-On Delay Time		t _{d(on)}		39.2		ns
Rise Time	$(V_{DD} = 225 \text{ V}, I_D = 21 \text{ A},$	t _r		89.8		ns
Turn-Off Delay Time	$R_G = 25\Omega)$ *	t _{d(off)}		92.8		ns
Fall Time		t _f		54.4		ns
Total Gate Charge	0/4 000 1/4 04 4	Q_g		61.2		nC
Gate-Source Charge	$(V_{DS} = 360 \text{ V}, I_{D} = 21 \text{ A},$	Q_gs		20.2		nC
Gate-Drain Charge	$V_{GS} = 10 \text{ V})^*$	Q_{qd}		22.5		nC
	SOURCE-DRAIN DIODE CH	ARACTERISTICS	•	•	•	•
Forward On-Voltage(1)		V _{SD}			1.5	V
Forward Turn-On Time	$(I_S = 21 \text{ A},$	t _{on}		**		ns
Reverse Recovery Time $d_{is}/d_t = 100A/\mu s$)		t _{rr}		474.7		ns

^{*} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%

^{**} Negligible, Dominated by circuit inductance



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TYPICAL ELECTRICAL CHARACTERISTICS

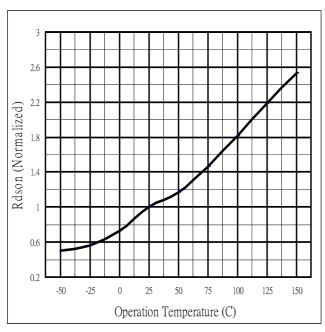


Fig 1. On-Resistance Variation with vs. Temperature

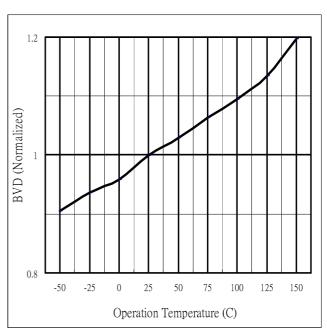


Fig.2 Breakdown Voltage Variation vs. Temperature

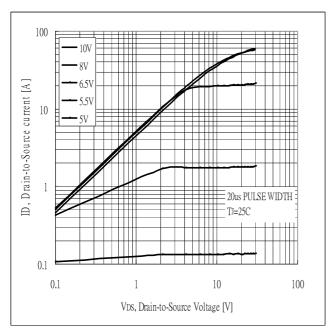


Fig 3. Typical Output Characteristics

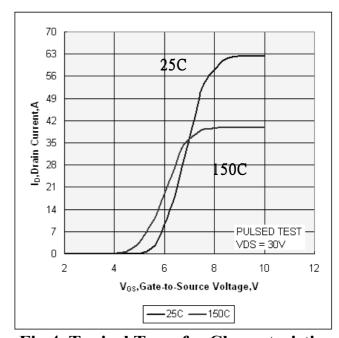


Fig 4. Typical Transfer Characteristics





POWER FIELD EFFECT TRANSISTOR

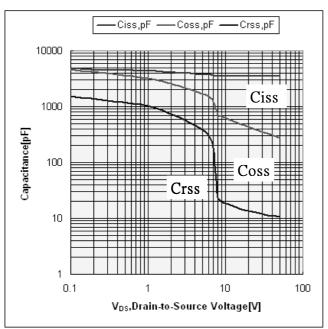


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

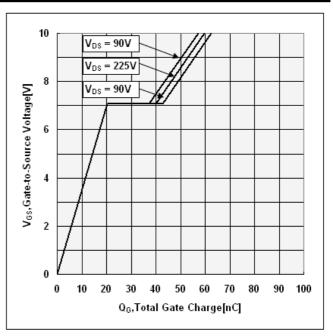


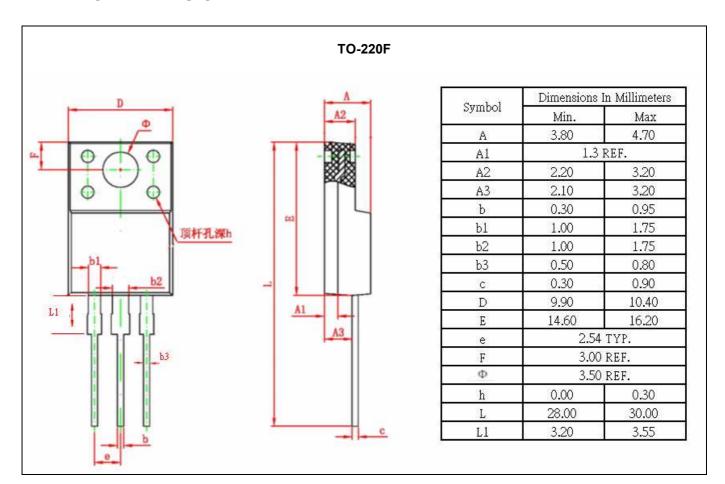
Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage





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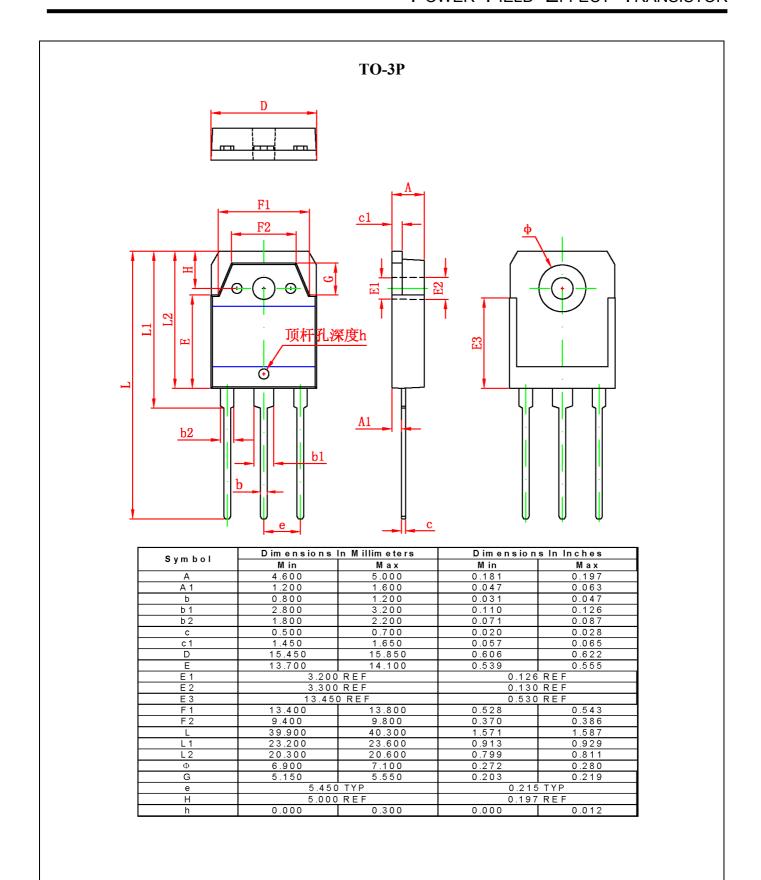
PACKAGE DIMENSION







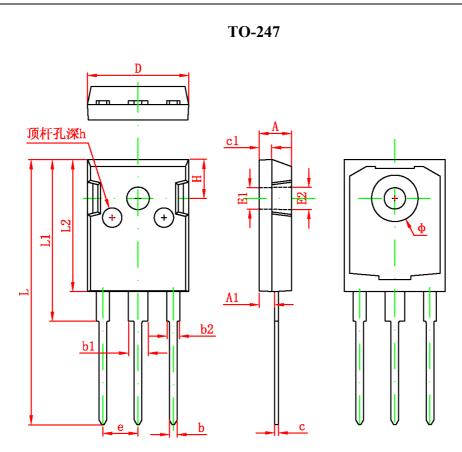
POWER FIELD EFFECT TRANSISTOR







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Symbol	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	Min	Max	Min	Max
Α	4.850	5.150	0.191	0.200
A1	2.200	2.600	0.087	0.102
b	1.000	1.400	0.039	0.055
b1	2.800	3.200	0.110	0.126
b2	1.800	2.200	0.071	0.087
С	0.500	0.700	0.020	0.028
c1	1.900	2.100	0.075	0.083
D	15.450	15.750	0.608	0.620
E1	3.500 REF		0.138 REF	
E2	3.600 REF		0.142 REF	
L	40.900	41.300	1.610	1.626
L1	24.800	25.100	0.976	0.988
L2	20.300	20.600	0.799	0.811
Ф	7.100	7.300	0.280	0.287
е	5.450 TYP		0.215	5 TYP
Н	5.980 REF		0.235 REF	
h	0.000	0.300	0.000	0.012





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IMPORTANT NOTICE

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